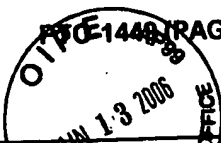


<b>INFORMATION DISCLOSURE STATEMENT</b> PTO-1449 (PAGE 1 OF 1) 	SERIAL NUMBER 10/629,793	DOCKET NO. P56905
	APPLICANT YOSHITAKA TERAO <i>et al.</i>	
	FILING DATE 30 July 2003	GROUP 2879

### U.S. PATENT DOCUMENTS

EXAMINER	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE

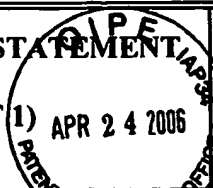
### FOREIGN PATENT DOCUMENTS

						TRANSLATION	
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	YES	NO
JW	JP 09-274859	10/21/97	JAPAN			Abstract	
JW	JP 09-283032	10/31/97	JAPAN			Abstract	

### OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)


EXAMINER: /Joseph Williams/ (11/26/2006) CONSIDERED: 11/26/2006

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<b>INFORMATION DISCLOSURE STATEMENT</b>  <b>PTO-1449 (PAGE 1 OF 1)</b>		SERIAL NUMBER 10/629,793	DOCKET NO. P56905
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U.S. PATENT DOCUMENTS							
EXAMINER	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE	

FOREIGN PATENT DOCUMENTS						TRANSLATION	
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	YES	NO
JW	JP 2001-060434	03/01	JAPAN			Abstract	
JW	JP 11-096911	04/99	JAPAN			Abstract	
JW	JP 06-251714	09/94	JAPAN			Abstract	

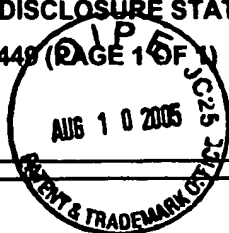
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)	

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# INFORMATION DISCLOSURE STATEMENT

PTO-1449 (PAGE 1 OF 1)



SERIAL NUMBER 10/629,793

DOCKET NO. P56905

APPLICANT CHA-KEUN YOON, *et al.*

FILING DATE 30 July 2003

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## U.S. PATENT DOCUMENTS

EXAMINER	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE

## FOREIGN PATENT DOCUMENTS

## TRANSLATION

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	YES	NO
JW	JP 11-273557	10/99	JAPAN			Abstract	
JW	KR 10-0303907	07/01	KOREA			Abstract	

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)


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